

Search Notes

Application/Control No.

10/665,782

Examiner

Duc M. Nguyen

Applicant(s)/Patent under
Reexamination

RACHABATHUNI ET AL.

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
455	456.1--> 456.6		
	414.1		
	414.2		
	414.3		
	432.1		
	432.3		
	433 435.1		
	566 567		
	518 519		
340	988-->		
	-> 994		
705	10 26	8/18/2005	DN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner